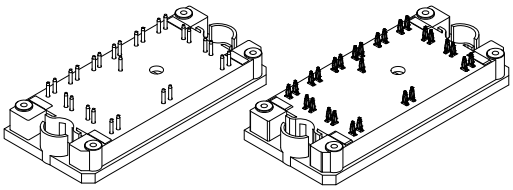
Q1PACK Module

NXH50M65L4Q1SG, NXH50M65L4Q1PTG

50 A, 650 V Module

This high−density, integrated power module combines high−performance IGBTs with rugged anti−parallel diodes.



PIM27, 71x37.4
(SOLDER PIN)
CASE 180CA

PIM27, 71x37.4
(PRESSFIT PIN)
CASE 180CP

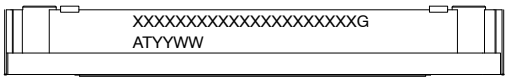
Features

- Extremely Efficient Trench with Fieldstop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Q1PACK Packages with Solder and Pressfit Pins

Typical Applications

- Solar Inverters
- Uninterruptable Power Supplies

MARKING DIAGRAM



XXXXX	= Specific Device Code
G	= Pb−Free Package
AT	= Assembly & Test Site Code
YYWW	= Year and Work Week Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

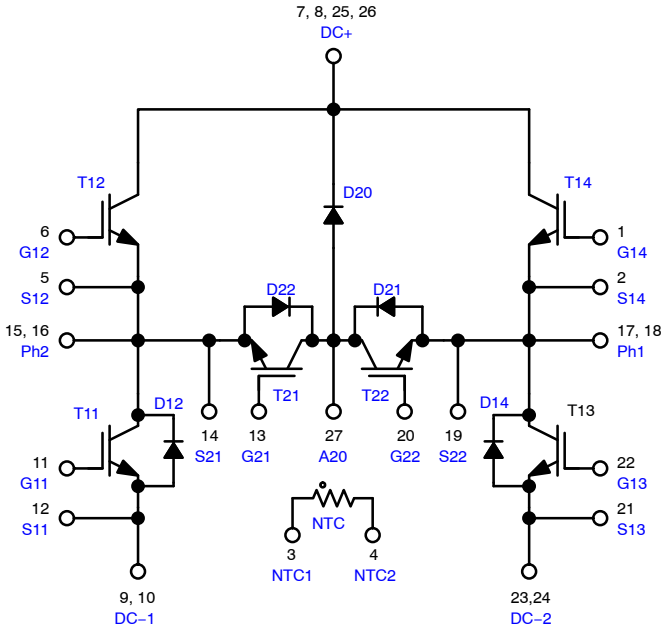


Figure 1. Schematic

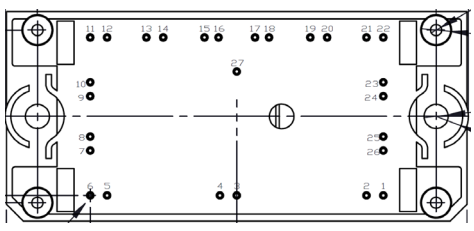


Figure 2. Pin Assignments

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
IGBT (T11, T12, T13, T14, T21, T22)			
Collector−emitter voltage	V_{CES}	650	V
Collector current @ T_h = 80°C (per IGBT)	I_C	48	A
Pulsed collector current, T_{pulse} limited by T_{jmax}	I_{CM}	144	A
Power Dissipation Per IGBT $T_j = T_{jmax}$, T_h = 80°C	P_{tot}	72	W
Gate−emitter voltage	V_{GE}	±20	V
Maximum Junction Temperature	T_J	175	°C
DIODE (D12, D14, D20, D21, D22)			
Peak Repetitive Reverse Voltage	V_{RRM}	650	V
Forward Current, DC @ T_h = 80°C (per Diode)	I_F	50	A
Nonrepetitive Peak Surge Current (Surge applied at rated load conditions halfwave, single phase, 60 Hz)	I_{FSM}	225	A
Power Dissipation Per Diode $T_j = T_{jmax}$, T_h = 80°C	P_{tot}	86	W
Maximum Junction Temperature	T_J	175	°C
THERMAL PROPERTIES			
Operating Temperature under switching condition	$T_{VJ\ OP}$	−40 to (T_{jmax} − 25)	°C
Storage Temperature range	T_{stg}	−40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 2 min, 60 Hz	V_{is}	4000	Vac
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Condition	Symbol	Min	Typ	Max	Unit
IGBT (T11, T12, T13, T14, T21, T22)						
Collector−emitter cutoff current	V_{GE} = 0 V, V_{CE} = 650 V	I_{CES}	–	–	300	μA
Collector−emitter saturation voltage	V_{GE} = 15 V, I_C = 50 A, T_j = 25°C V_{GE} = 15 V, I_C = 50 A, T_j = 150°C	$V_{CE(sat)}$	– –	1.56 1.76	2.22 –	V
Gate−emitter threshold voltage	V_{GE} = V_{CE}, I_C = 50mA	$V_{GE(TH)}$	3.1	4.45	5.2	V
Gate leakage current	V_{GE} = 20 V, V_{CE} = 0 V	I_{GES}	–	–	400	nA
Turn−on delay time	T_j = 25°C V_{CE} =350 V, I_C = 50 A V_{GE} = 15 V, −9 V, R_G = 6 Ω	$t_{d(on)}$	–	14	–	ns
Rise time		t_r	–	20	–	
Turn−off delay time		$t_{d(off)}$	–	68	–	
Fall time		t_f	–	20	–	
Turn on switching loss		E_{on}	–	0.46	–	mJ
Turn off switching loss		E_{off}	–	0.44	–	
Turn−on delay time	T_j = 125°C V_{CE} = 350 V, I_C = 50 A V_{GE} = 15 V, −9 V, R_G = 6 Ω	$t_{d(on)}$	–	16	–	ns
Rise time		t_r	–	23	–	
Turn−off delay time		$t_{d(off)}$	–	78	–	
Fall time		t_f	–	52	–	
Turn on switching loss		E_{on}	–	0.78	–	mJ
Turn off switching loss		E_{off}	–	0.60	–	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Parameter	Test Condition	Symbol	Min	Typ	Max	Unit
IGBT (T11, T12, T13, T14, T21, T22)						
Input capacitance	V_{CE} = 20 V, V_{GE} = 0 V, f = 1 MHz	C_{ies}	–	3137	–	pF
Output capacitance		C_{oes}	–	146	–	
Reverse transfer capacitance		C_{res}	–	17	–	
Gate charge total	V_{CE} = 350 V, I_C = 40 A, V_{GE} = ±15 V	Q_g	–	180	–	nC
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK	R_{thJH}	–	1.32	–	°C/W
Thermal Resistance – chip–to–case		R_{thJC}	–	0.96	–	°C/W
IGBT INVERSE DIODE (D12, D14, D21, D22)						
Forward voltage	I_F = 50 A, T_j = 25°C I_F = 50 A, T_j = 175°C	V_F	– –	2.25 1.7	2.7 –	V
Reverse Recovery Time	T_j = 25°C V_{CE} = 350 V, I_C = 50 A V_{GE} = 15 V, –9 V, R_G = 6 Ω	t_{rr}	–	28	–	ns
Reverse Recovery Current		Q_{rr}	–	281	–	nc
Peak Reverse Recovery Current		I_{rrm}	–	18	–	A
Peak Rate of Fall of Recovery Current		Di/dt_{max}	–	1.42	–	A/μs
Reverse Recovery Energy		E_{rr}	–	33	–	μJ
Reverse Recovery Time	T_j = 125°C V_{CE} = 350 V, I_C = 50 A V_{GE} = 15 V, –9 V, R_G = 6 Ω	t_{rr}	–	65	–	ns
Reverse Recovery Current		Q_{rr}	–	1094	–	nc
Peak Reverse Recovery Current		I_{rrm}	–	33	–	A
Peak Rate of Fall of Recovery Current		Di/dt_{max}	–	1.32	–	A/μs
Reverse Recovery Energy		E_{rr}	–	198	–	μJ
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK	R_{thJH}	–	1.10	–	°C/W
Thermal Resistance – chip–to–case		R_{thJC}	–	0.79	–	°C/W
DIODE (D20)						
Forward voltage	I_F = 50 A, T_j = 25°C I_F = 50 A, T_j = 175°C	V_F	– –	2.25 1.7	2.7 –	V
Reverse leakage current	V_{CE} = 650 V, V_{GE} = 0 V	I_r	–	–	300	μA
Thermal Resistance – chip–to–heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK	R_{thJH}	–	1.10	–	°C/W
Thermal Resistance – chip–to–case		R_{thJC}	–	0.79	–	°C/W
THERMISTOR CHARACTERISTICS						
Nominal resistance	T = 25°C	R_{25}	–	22	–	kΩ
Nominal resistance	T = 100°C	R_{100}	–	1486	–	Ω
Deviation of R25		R/R	–5	–	5	%
Power dissipation		P_D	–	200	–	mW
Power dissipation constant			–	2	–	mW/°C
B–value	B (25/50), tol ±3%		–	–	3950	°C
B–value	B (25/100), tol ±3%		–	–	3998	°C
NTC reference			–	–	B	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS – IGBT (T11, T12, T13, T14, T21, T22)

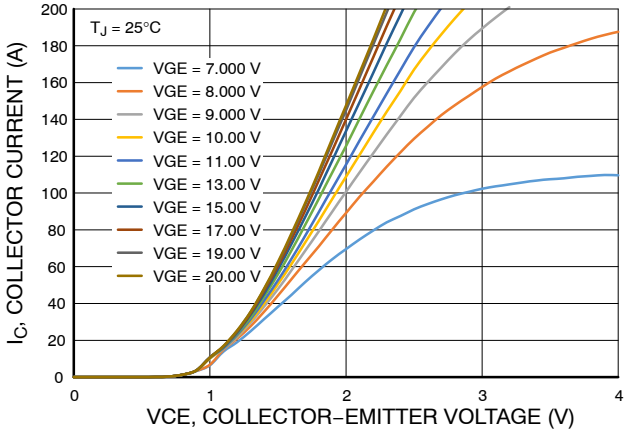


Figure 3. Typical Output Characteristics

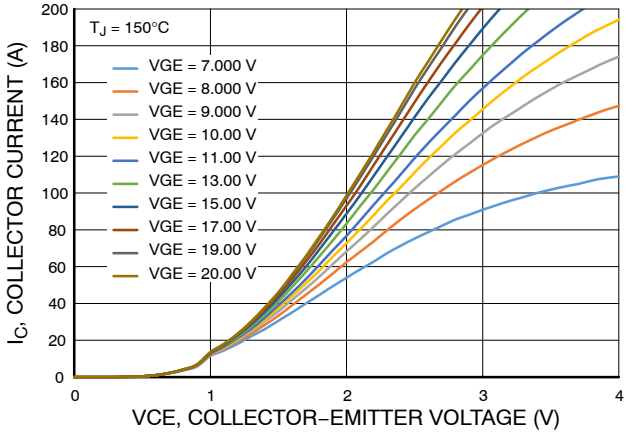


Figure 4. Typical Output Characteristics

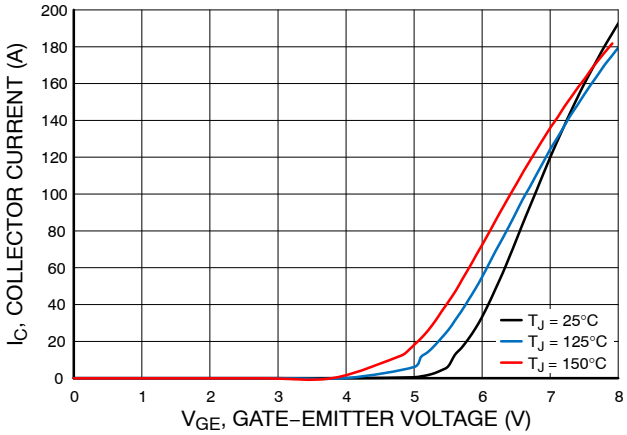


Figure 5. Typical Transfer Characteristics

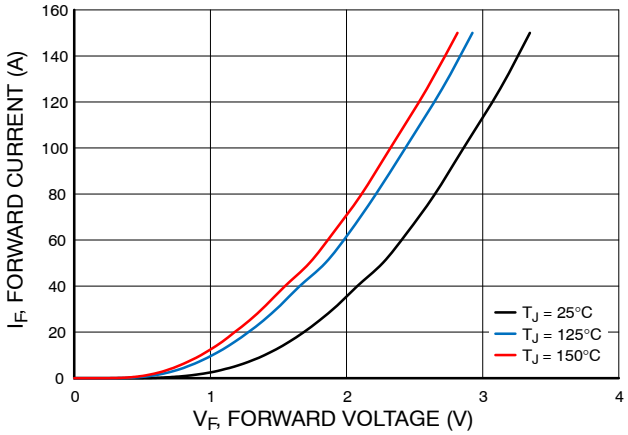


Figure 6. Diode Forward Characteristics

TYPICAL CHARACTERISTICS – (T11, T12, T13, T14) IGBT COMMUTATES D21, D22 DIODE

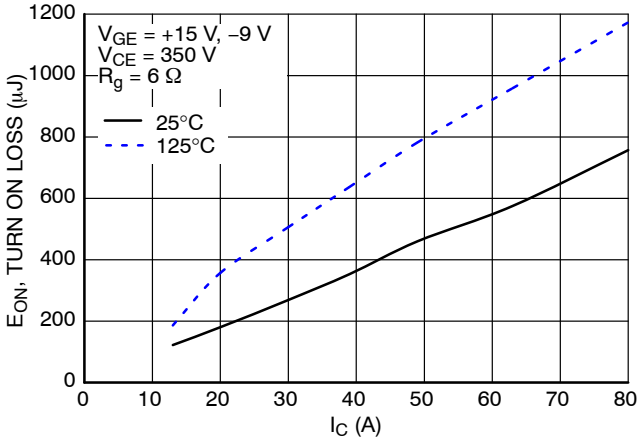


Figure 7. Typical Turn ON Loss vs. IC

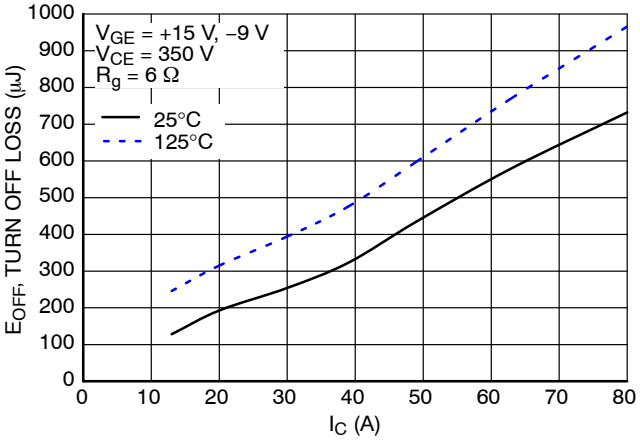


Figure 8. Typical Turn OFF Loss vs. IC

TYPICAL CHARACTERISTICS – (T11, T12, T13, T14) IGBT COMMUTATES D21, D22 DIODE (CONTINUED)

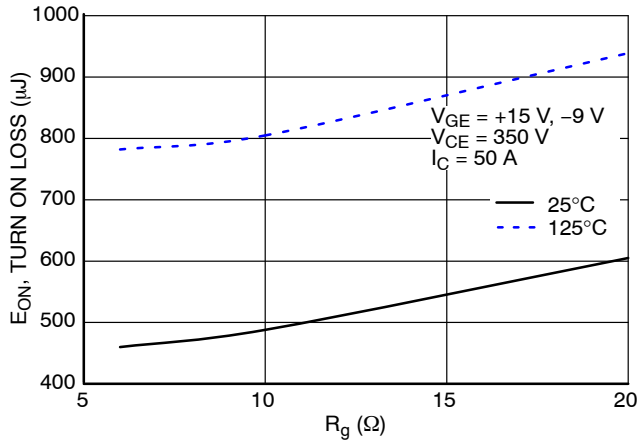


Figure 9. Typical Turn ON Loss vs. RG

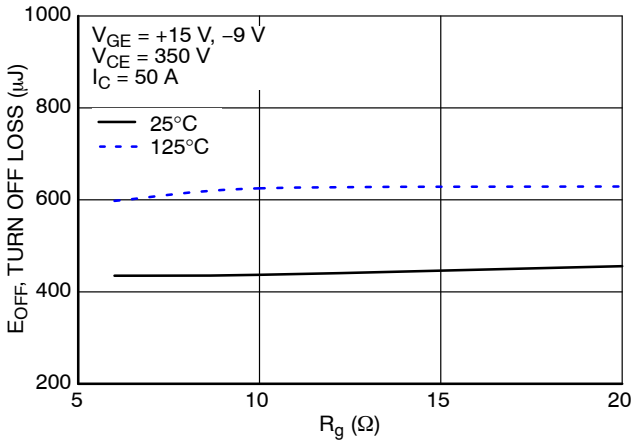


Figure 10. Typical Turn OFF Loss vs. RG

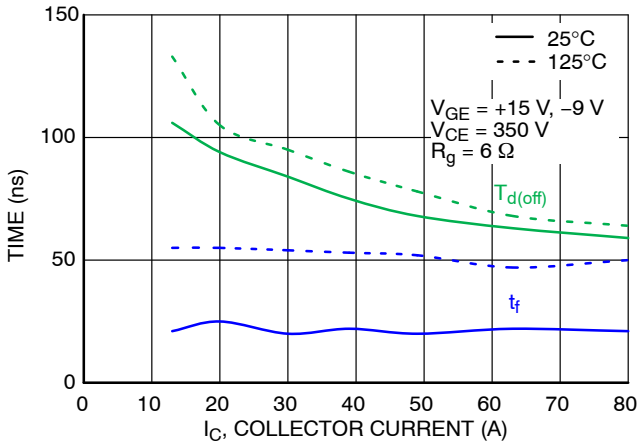


Figure 11. Typical Turn−Off Switching Time vs. IC

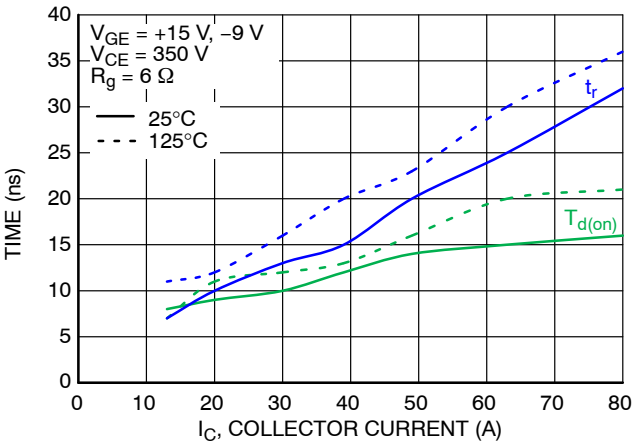


Figure 12. Typical Turn−On Switching Time vs. IC

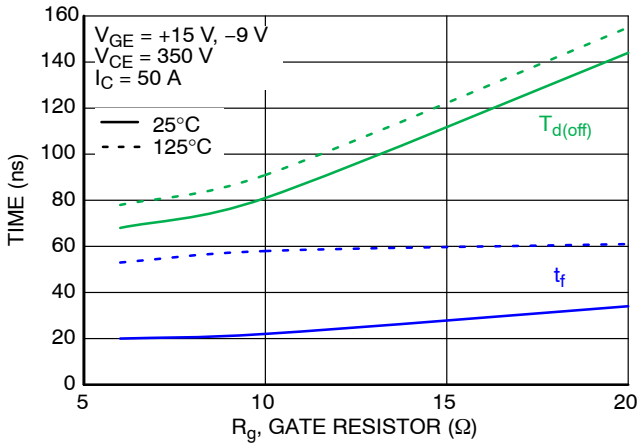


Figure 13. Typical Turn−Off Switching Time vs. Rg

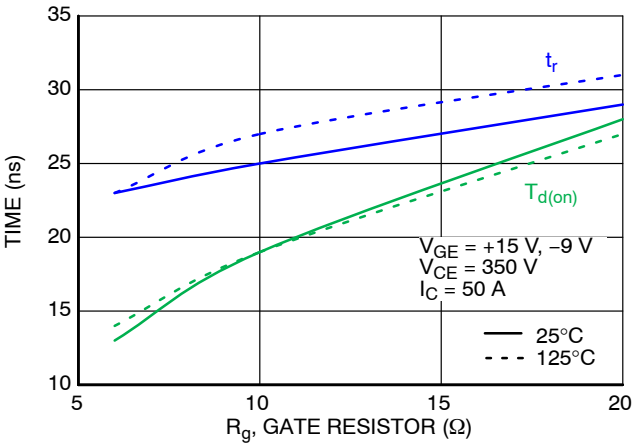


Figure 14. Typical Turn−On Switching Time vs. Rg

TYPICAL CHARACTERISTICS – (T21, T22) IGBT COMMUTATES D20 DIODE

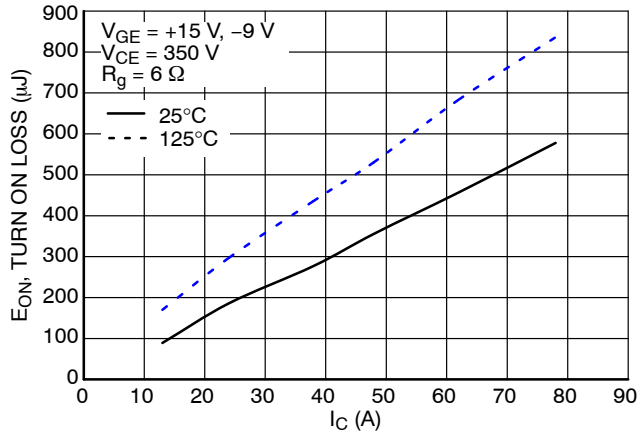


Figure 15. Typical Turn ON Loss vs. IC

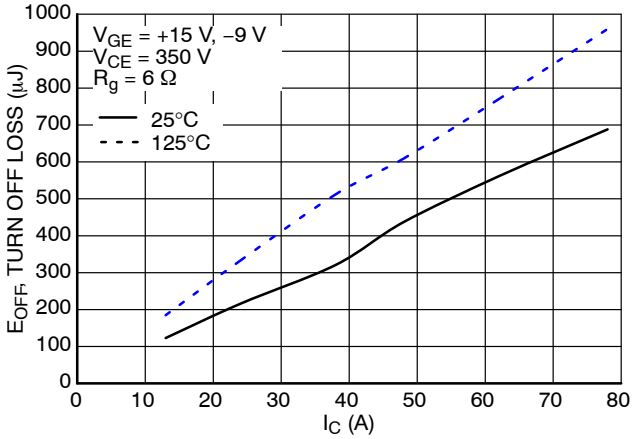


Figure 16. Typical Turn OFF Loss vs. IC

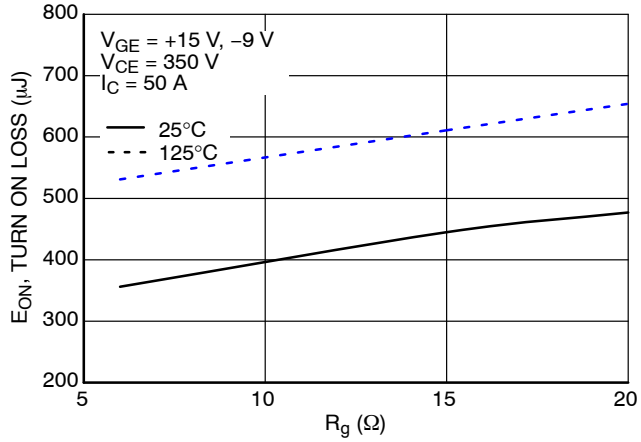


Figure 17. Typical Turn ON Loss vs. RG

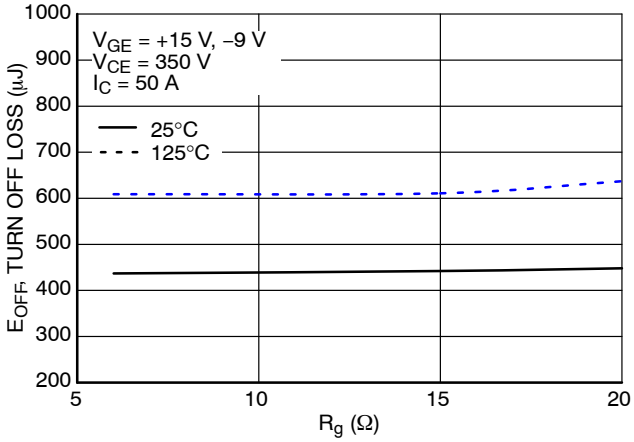


Figure 18. Typical Turn OFF Loss vs. RG

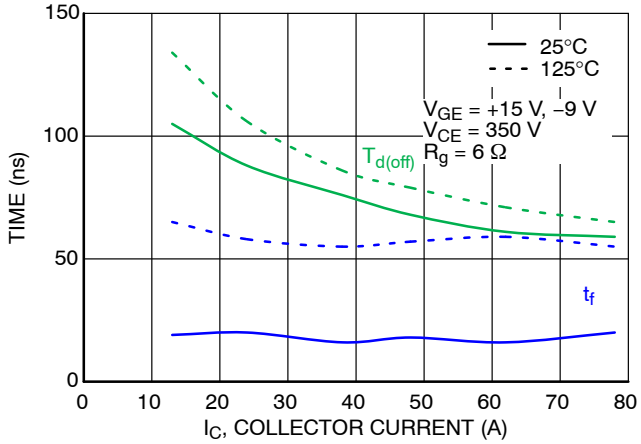


Figure 19. Typical Turn−Off Switching Time vs. IC

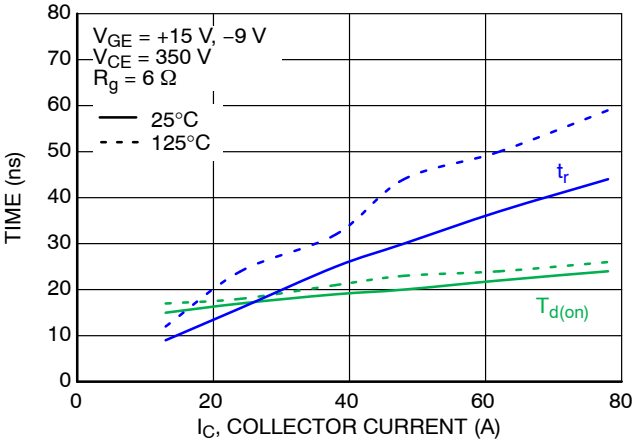


Figure 20. Typical Turn−On Switching Time vs. IC

TYPICAL CHARACTERISTICS – (T21, T22) IGBT COMMUTATES D20 DIODE (CONTINUED)

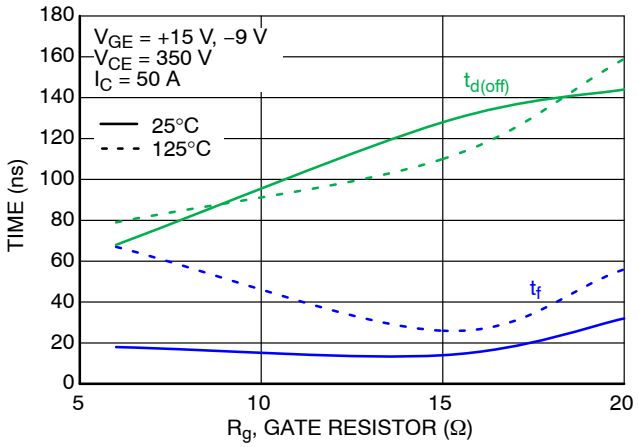


Figure 21. Typical Turn−Off Switching Time vs. Rg

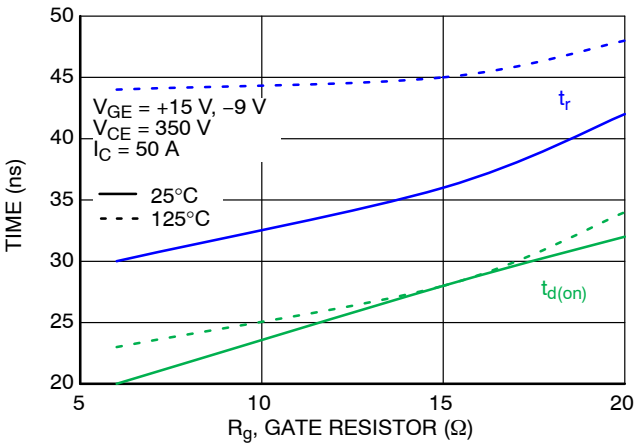


Figure 22. Typical Turn−On Switching Time vs. Rg

TYPICAL CHARACTERISTICS – DIODE

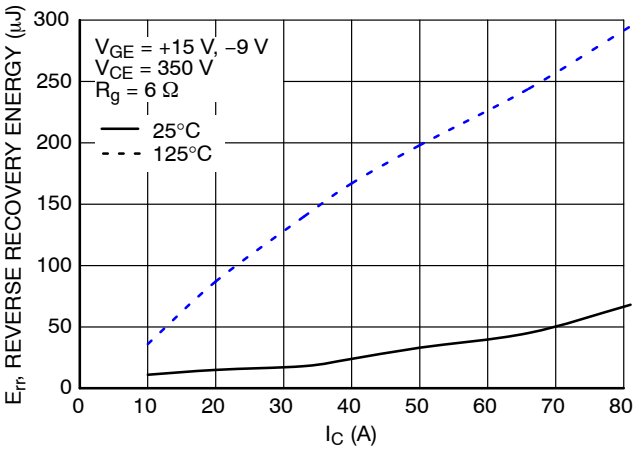


Figure 23. Typical Reverse Recovery Energy Loss vs. IC

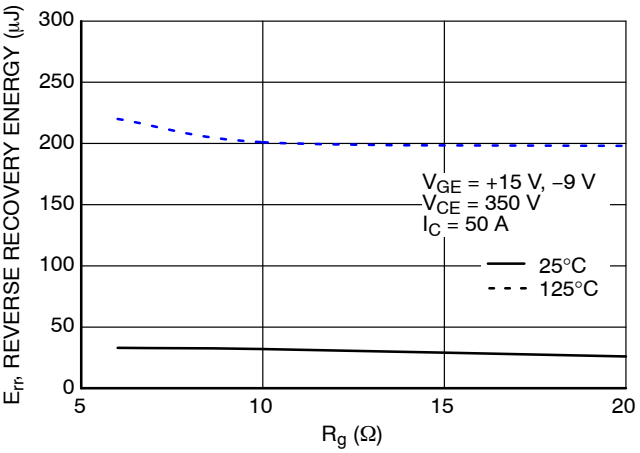


Figure 24. Typical Reverse Recovery Energy Loss vs. RG

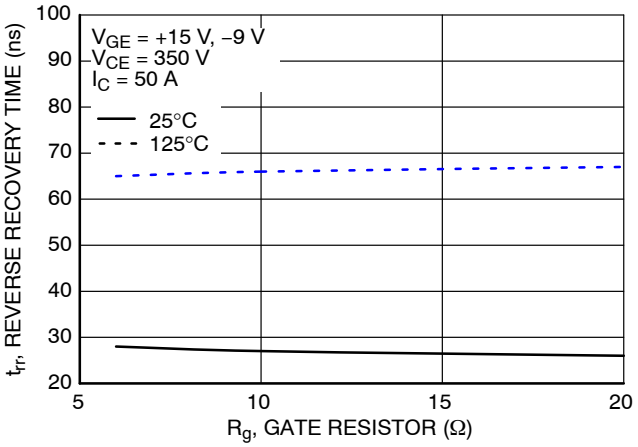


Figure 25. Typical Reverse Recovery Time vs. Rg

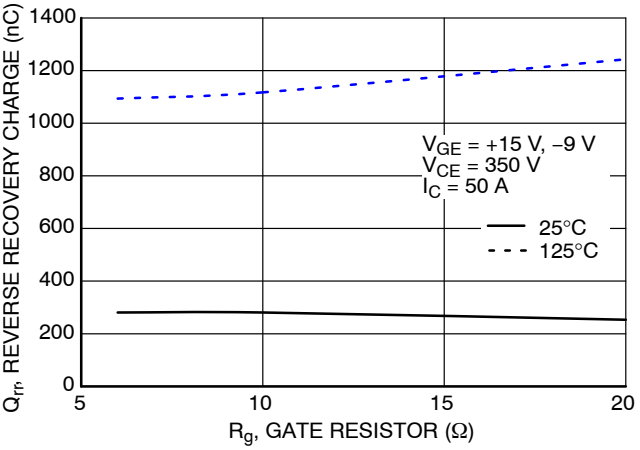


Figure 26. Typical Reverse Recovery Charge vs. Rg

TYPICAL CHARACTERISTICS – DIODE (CONTINUED)

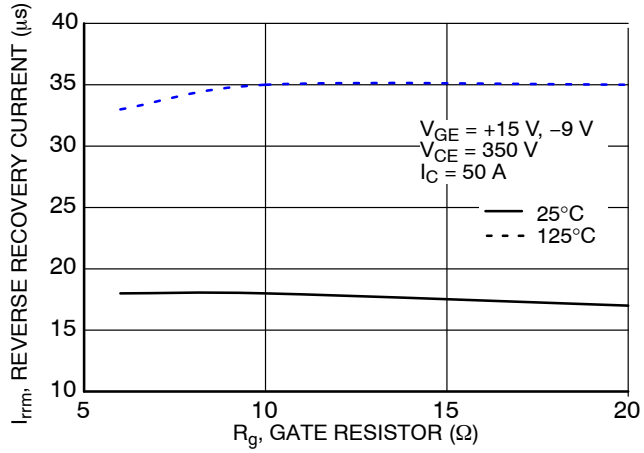


Figure 27. Typical Reverse Recovery Peak Current vs. Rg

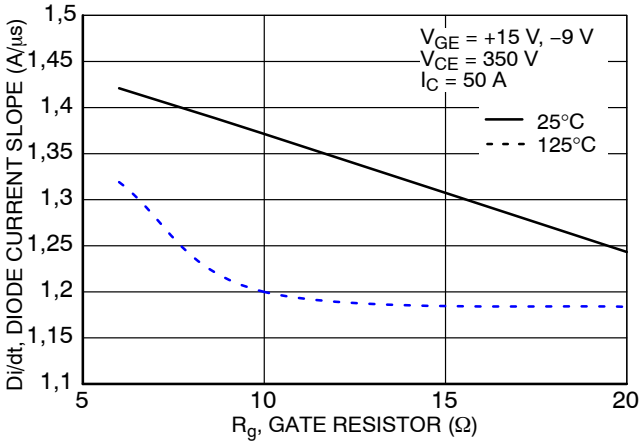


Figure 28. Typical di/dt vs. Rg

TYPICAL CHARACTERISTICS

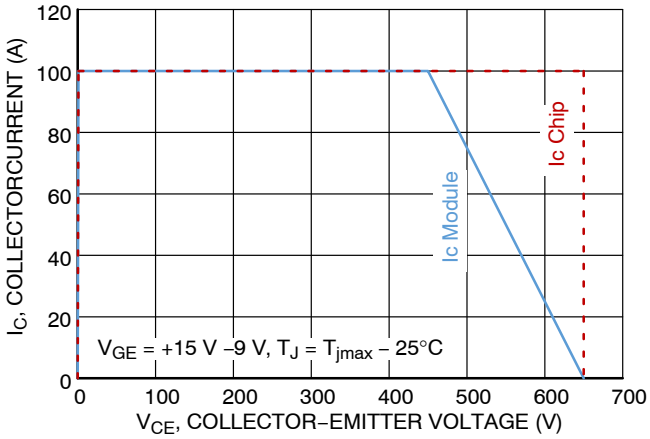


Figure 29. RBSOA Reverse Safe Operating Area

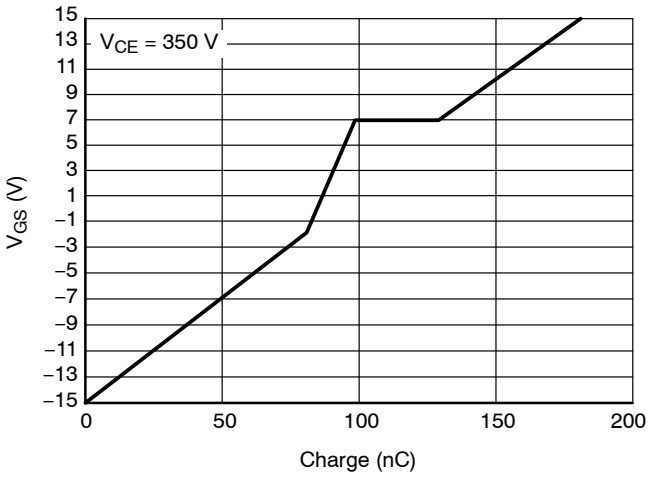


Figure 30. IGBT Gate Charge

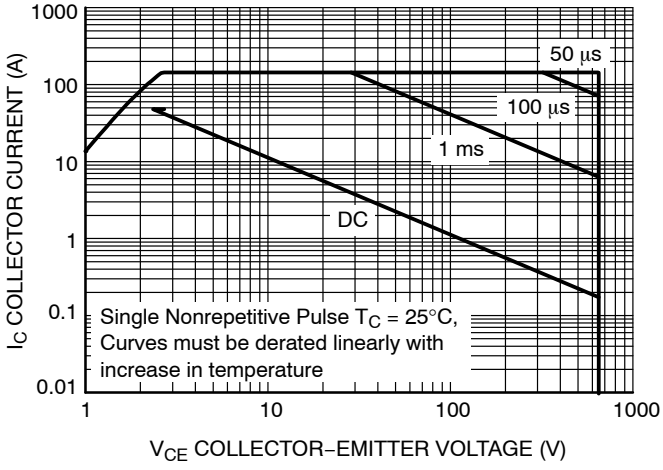


Figure 31. IGBT Safe Operating Area

TYPICAL THERMAL CHARACTERISTICS

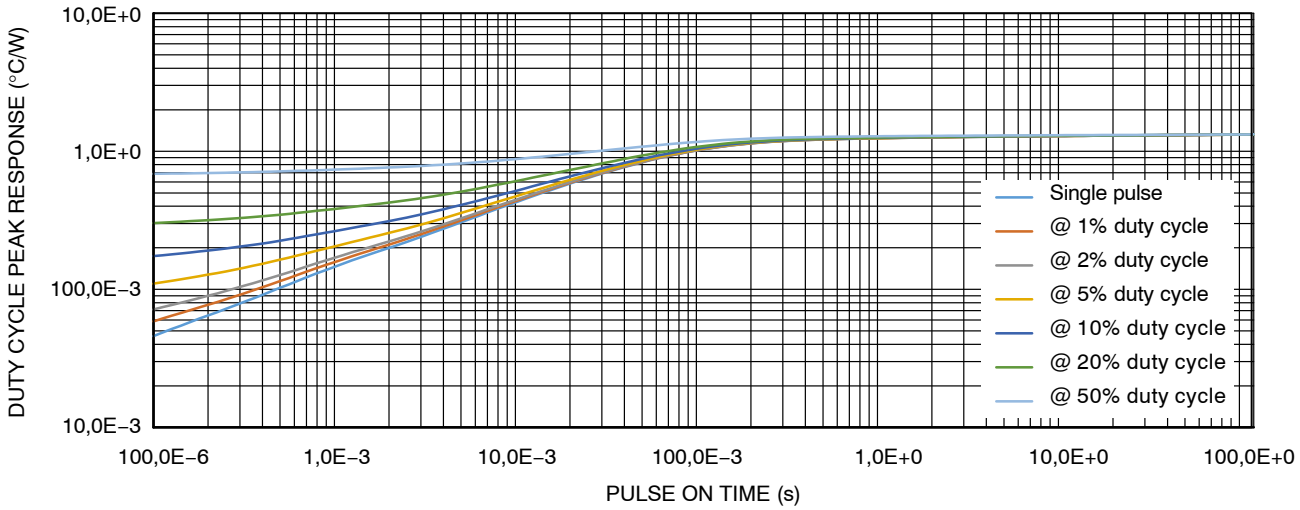


Figure 32. Transient Thermal Impedance – IGBT

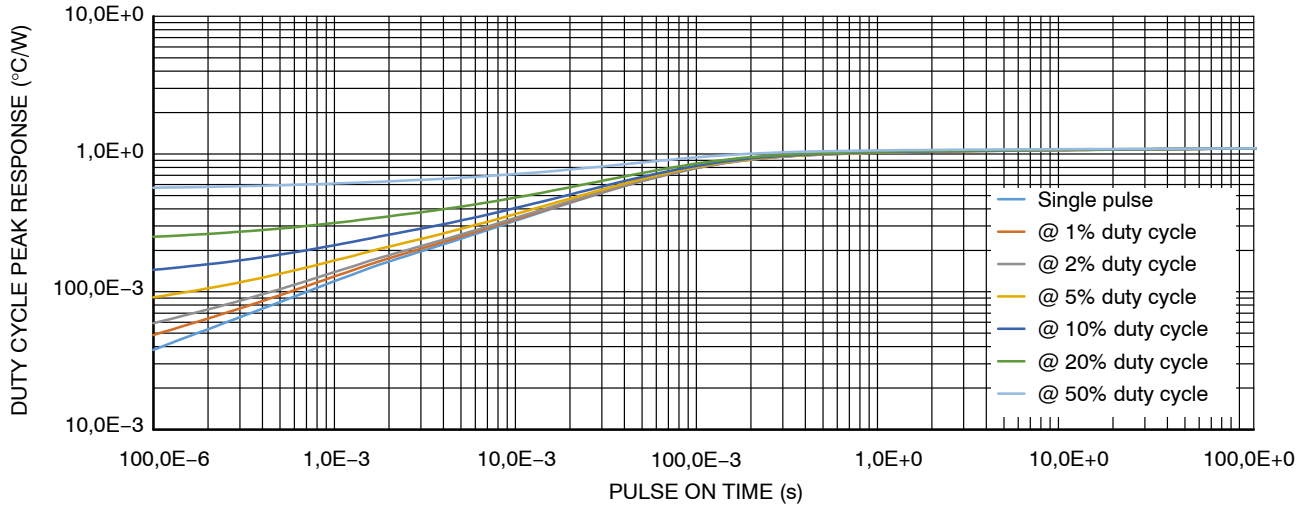
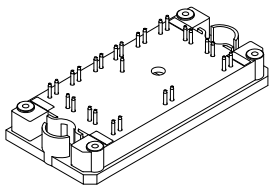


Figure 33. Transient Thermal Impedance – Diode

ORDERING INFORMATION

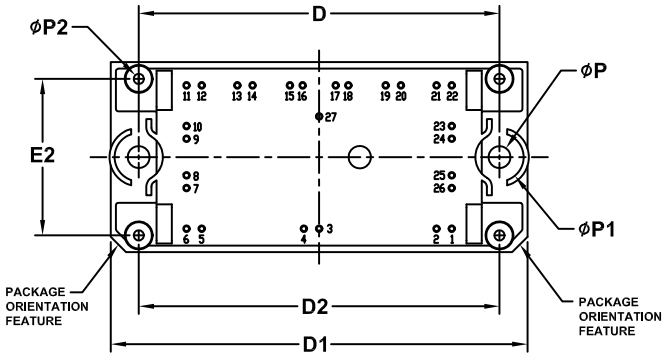
Device	Package Type	Status	Shipping
NXH50M65L4Q1SG (Solder Pin)	PIM27, 71x37.4 Q1PACK	In Development	21 Units / BTRAY
NXH50M65L4Q1PTG (Pressfit Pin)	PIM27, 71x37.4 Q1PACK	In Development	21 Units / BTRAY

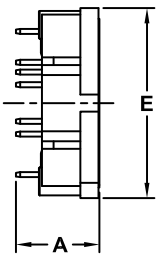
MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS



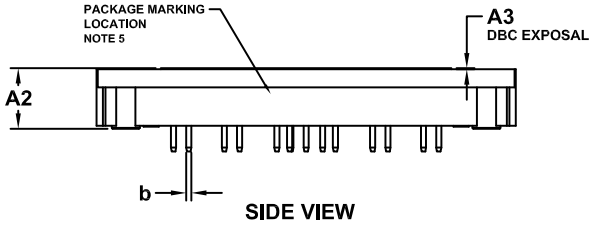
PIM27, 71x37.4 (SOLDER PIN)
CASE 180CA
ISSUE B

DATE 14 DEC 2022





DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	15.90	16.40	16.90
A2	11.70	11.90	12.10
A3	0.00	0.20	0.60
b	0.95	1.00	1.05
b1	0.75	0.80	0.85
D	70.80	71.00	71.20
D1	81.70	82.00	82.30
D2	70.80	71.00	71.20
E	37.10	37.40	37.70
E2	30.60	30.80	31.00
P	4.10	4.30	4.50
P1	9.30	9.50	9.70
P2	1.80	2.00	2.20



NOTES:

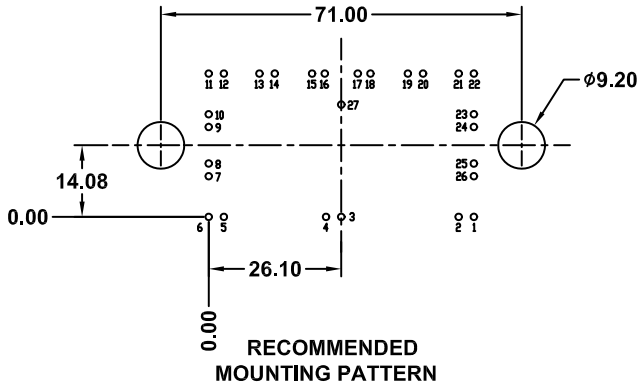
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
2. CONTROLLING DIMENSION : MILLIMETERS
3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
4. PIN POSITION TOLERANCE IS ± 0.4mm
5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES

NOTE 4

PIN	PIN POSITION		PIN	PIN POSITION	
	X	Y		X	Y
1	52.20	0.00	15	20.35	28.20
2	49.20	0.00	16	22.85	28.20
3	26.10	0.00	17	29.35	28.20
4	23.10	0.00	18	31.85	28.20
5	3.00	0.00	19	39.20	28.20
6	0.00	0.00	20	42.20	28.20
7	0.00	8.00	21	49.20	28.20
8	0.00	10.50	22	52.20	28.20
9	0.00	17.70	23	52.20	20.20
10	0.00	20.20	24	52.20	17.70
11	0.00	28.20	25	52.20	10.50
12	3.00	28.20	26	52.20	8.00
13	10.00	28.20	27	26.10	22.10
14	13.00	28.20			

PIM27, 71x37.4 (SOLDER PIN)
CASE 180CA
ISSUE B

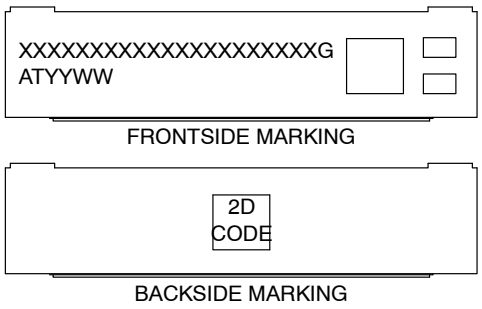
DATE 14 DEC 2022



RECOMMENDED MOUNTING PATTERN

* For additional Information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code
G = Pb−Free Device
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “ ▪”, may or may not be present. Some products may not follow the Generic Marking.

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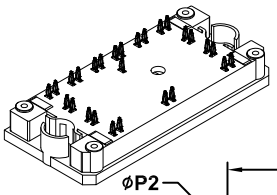
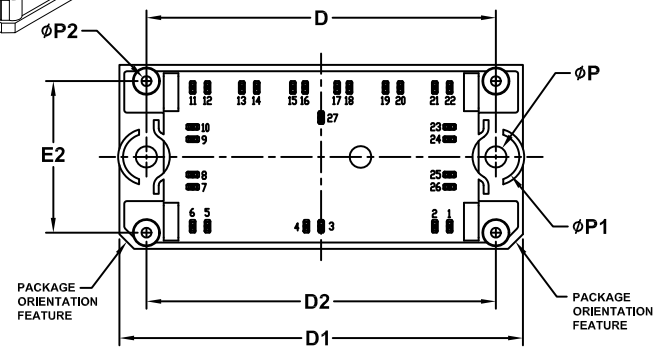
DESCRIPTION:	**PIM27, 71X37.4 (SOLDER PIN)**	**PAGE 2 OF 2**

MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

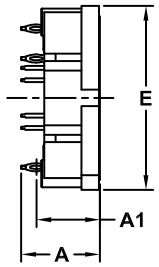
PIM27, 71x37.4 (PRESSFIT PIN)
CASE 180CP
ISSUE A

DATE 20 DEC 2022





TOP VIEW



END VIEW

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	15.50	16.00	16.50
A1	12.38	12.88	13.38
A2	11.70	11.90	12.10
A3	0.00	0.20	0.60
b	1.61	1.66	1.71
b1	0.75	0.80	0.85
D	70.80	71.00	71.20
D1	81.70	82.00	82.30
D2	70.80	71.00	71.20
E	37.10	37.40	37.70
E2	30.60	30.80	31.00
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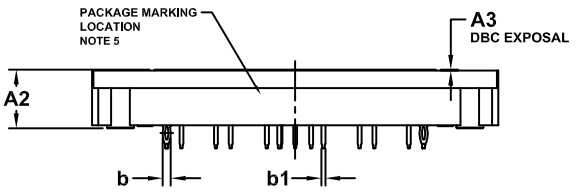

SIDE VIEW

NOTE 4

PIN	PIN POSITION	
	X	Y
1	52.20	0.00
2	49.20	0.00
3	26.10	0.00
4	23.10	0.00
5	3.00	0.00
6	0.00	0.00
7	0.00	8.00
8	0.00	10.50
9	0.00	17.70
10	0.00	20.20
11	0.00	28.20
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14	13.00	28.20

PIN	PIN POSITION	
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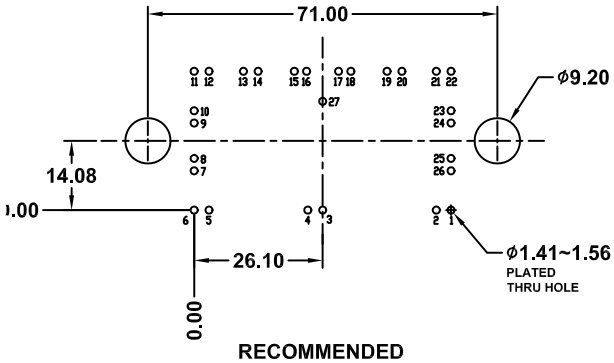
16	22.85	28.20
17	29.35	28.20
18	31.85	28.20
19	39.20	28.20
20	42.20	28.20
21	49.20	28.20
22	52.20	28.20
23	52.20	20.20
24	52.20	17.70
25	52.20	10.50
26	52.20	8.00
27	26.10	22.10



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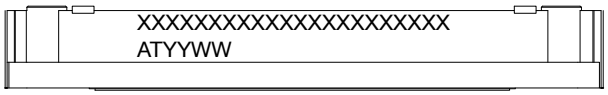

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*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “ ▪”, may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	**PIM27, 71X37.4 (PRESSFIT PIN)**	**PAGE 1 OF 1**

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